

WEST[Help](#)[Logout](#)[Interrupt](#)[Main Menu](#)[Search Form](#)[Posting Counts](#)[Show S Numbers](#)[Edit S Numbers](#)[Preferences](#)**Search Results -**

Terms	Documents
12 and (detect\$5 near3 (alignment adj mark))	30

Database:

[US Patents Full-Text Database](#)
[US Pre-Grant Publication Full-Text Database](#)
[JPO Abstracts Database](#)
[EPO Abstracts Database](#)
[Derwent World Patents Index](#)
[IBM Technical Disclosure Bulletins](#)

Refine Search:

12 and (detect\$5 near3 (alignment adj mark))

[Clear](#)**Search History****Today's Date: 12/13/2001**

<u>DB Name</u>	<u>Query</u>	<u>Hit Count</u>	<u>Set Name</u>
PGPB,JPAB,EPAB,DWPI,TDBD	12 and (detect\$5 near3 (alignment adj mark))	30	<u>L7</u>
USPT	12 and (detect\$5 near3 (alignment adj mark))	0	<u>L6</u>
USPT	11 and (detect\$5 near3 (alignment adj mark))	39	<u>L5</u>
USPT	11 and (alignment adj mark)	84	<u>L4</u>
PGPB,JPAB,EPAB,DWPI,TDBD	12 and (alignment adj mark)	65	<u>L3</u>
PGPB,JPAB,EPAB,DWPI,TDBD	(charged adj1 particle adj1 beam) or cpb	5210	<u>L2</u>
USPT	(charged adj1 particle adj1 beam) or cpb	2469	<u>L1</u>